

Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
09/673,702	FAHRAEUS ET	FAHRAEUS ET AL.	
Examiner	Art Unit		
Wenpeng Chen	2624		

SEARCHED				
Class	Subclass	Date	Examiner	
382	313 324 186	9/21/05	are	
	(updated Dearch)			
	partin)			
<del>-</del>				
· · · · · · · · · · · · · · · · · · ·				
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen history		7/22/1	ar	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - updated search, See search history printout.	9/21/03	an